



Workshop on Cyber Security

Global ICT Standardisation Forum for India (GISFI) and IETE

Date: Wednesday, June 3, 2015

Venue: IETE, New Delhi

URL: http://gisfi.org/news_meeting_details.php?id=106&mno=21st

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Cyber-attacks are increasingly impacting businesses, privacy of individuals as well as security of nations. This has led to creation of cyber defense mechanisms worldwide but still the attacks continue. Hand-in-hand to cyber-attacks, technology enhancement is taking place at a fast pace leading to increasing connectivity in the form of 5G, Internet of Things (IoT), Machine to Machine (M2M), Smart city, Smart vehicle, Smart Homes, Smart Grid, Connected Devices, that also encompass the “Digital India” concept. Ever increasing connectivity and sophistication of attacks calls for concrete steps by all parties to prevent and defend from cyber-attacks.

The Global ICT Standardisation Forum for India (GISFI) Security & Privacy Working Group (S&P WG) has been working on Cyber Security. S&P WG is developing solutions and recommendations regarding cyber-attacks together with TTC of Japan – PRACTICE project. Solutions of PRACTICE project that is used to monitor cyber-attack is deployed by GISFI membership. Results of this collaboration and future plans will also be presented in the workshop by both GISFI and participants from TTC Japan.

This one-day workshop, organized by GISFI and IETE, is a platform for broad discussion among all parties on various aspects of cyber security. The workshop is divided in four parts: (1) Regulatory, (2) Industry, (3) Technical & Standards and (4) Future Considerations. The workshop is meant for practitioners as well decision makers from IT, telecommunications and of course information security. Key players of all “connected” parties are expected to participate and bring input to this workshop.

As there are limited seats, participants are requested to register at info@gisfi.org. Please feel free contact us to get more information. Workshop participation is free of cost.